## Notice of References Cited Application/Control No. 09/580,454 Examiner Chau Nguyen Applicant(s)/Patent Under Reexamination ONO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,649,218	07-1997	Saito, Kazuo	715/513
	В	US-6,526,410	02-2003	Aoyama et al.	707/102
	С	US-6,535,875	03-2003	Takahashi et al.	707/3
	D	US-6,230,173	05-2001	Ferrel et al.	715/513
	Е	US-5,553,216	09-1996	Yoshioka et al.	715/515
	F	US-5,983,248	11-1999	DeRose et al.	715/513
	G	US-5,778,400	07-1998	Tateno, Masakazu	715/513
	Н	US-5,802,529	09-1998	Nakatsuyama et al.	715/513
	1	US-5,745,745	04-1998	Tada et al.	707/1
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.